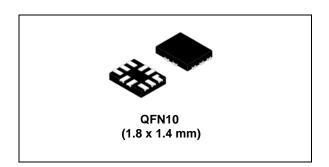
AS21P2THB



Low voltage high bandwidth dual single-pole double-throw analog switch

Datasheet - production data



Features

- Ultra low power dissipation:
 - $I_{CC} = 1 \mu A \text{ (max.) at } T_A = 85 \text{ °C}$
- Low "ON" resistance:
 - R_{ON} = 4.8 Ω (T_A = 25 °C) at V_{CC} = 4.3 V
 - $R_{ON} = 5.9 \Omega (T_A = 25 °C) at V_{CC} = 3.0 V$
- Wide operating voltage range:
 - V_{CC} (opr.) = 1.65 V to 4.3 V
- 4.3 V tolerant and 1.8 V compatible threshold on digital control input at V_{CC} = 2.3 V to 3.0 V
- Typical bandwidth (-3 dB) at 800 MHz on all channels
- USB (2.0) high speed (480 Mbps) signal switching compliant
- · Integrated fail safe function
- Interrupt function to indicate to the processor that the device is in dedicated port charging mode
- Latch-up performance exceeds 500 mA per JESD 78, Class II
- ESD performance exceeds JESD22:
 - Dn pins: 4000-V human body model (A114-A)
 - All other pins: 2000-V human body model (A114-A)

Applications

- Wearable
- Sport and fitness
- · Portable equipment

Description

The AS21P2THB is a high-speed CMOS low voltage dual analog SPDT (single pole double throw) switch or 2:1 multiplexer/demultiplexer switch fabricated in silicon gate C²MOS technology. It is designed to operate from 1.65 V to 4.3 V, thus making this device the ideal selection for portable applications.

The SEL input is provided to control the switch. The switch nS1 is ON (connected to common ports Dn) when the SEL input is held high and OFF (high impedance state exists between the two ports) when SEL is held low, the switch nS2 is ON (it is connected to common port Dn) when the SEL input is held low and OFF (high impedance state exists between the two ports) when SEL is held high. AS21P2THB has an integrated fail safe function to withstand over-voltage condition when the device is powered off.

The AS21P2THB also has an interrupt pin which sends a signal to the processor when the device is in dedicated port charging mode. Additional key features are fast switching speed, break-before-make-delay time and ultralow power consumption. All inputs and outputs are equipped with protection circuits against static discharge, giving them ESD immunity and transient excess voltage.

Table 1. Device summary

Order code	Package	Packaging
AS21P2THB	QFN10 (1.8 x 1.4 mm)	Tape and reel

March 2014 DocID026023 Rev 1 1/23

Contents AS21P2THB

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7	Package mechanical data
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AS21P2THB Pin settings

1 Pin settings

Figure 1. Pin connection (top through view)

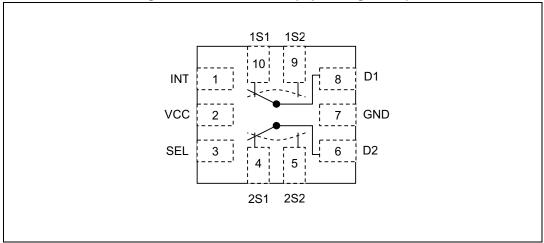


Table 2. Pin description

Pin number	Symbol	Name and function
1	INT	Interrupt
2	VCC	Positive supply voltage
3	SEL	Control
4	2S1	Independent channel for switch 2
5	2S2	Independent channel for switch 2
6	D2	Common channel for switch 2
7	GND	Ground (0 V)
8	D1	Common channel for switch 1
9	1S2	Independent channel for switch 1
10	1S1	Independent channel for switch 1

Logic diagram AS21P2THB

2 Logic diagram

Figure 2. Logic block diagram

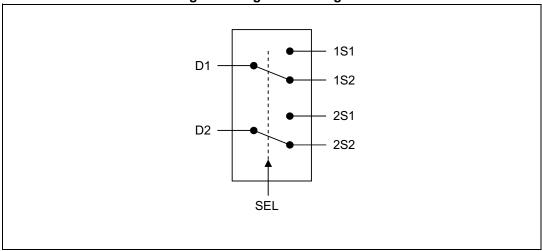


Figure 3. Logic equivalent circuit

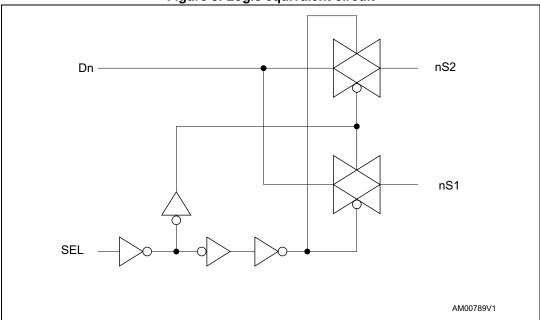


Table 3. Truth table

SEL	Switch nS1	Switch nS2
Н	ON	OFF ⁽¹⁾
L	OFF ⁽¹⁾	ON

1. High impedance.

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3 Dedicated port charging detection

The AS21P2THB has a built-in dedicated port charging detection circuit to detect the condition when the USB D+/D- lines are both in high state. When this occurs, the device sends an interrupt signal to the processor to indicate that the connected USB device is in dedicated port charging mode.

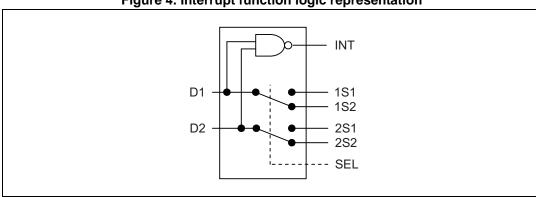


Figure 4. Interrupt function logic representation

Maximum rating AS21P2THB

4 Maximum rating

Stressing the device above the rating listed in the "Absolute maximum ratings" table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Table 4. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{CC}	Supply voltage	-0.5 to 5.5	V
VI	DC input voltage	-0.5 to V _{CC} + 0.5	V
V _{IC}	DC control input voltage	-0.5 to 5.5	V
V _O	DC output voltage	-0.5 to V _{CC} + 0.5	V
I _{IKC}	DC input diode current on control pin (V _{SEL} < 0V)	-50	mA
I _{IK}	DC input diode current (V _{SEL} < 0V)	±50	mA
I _{OK}	DC output diode current	±20	mA
I _O	DC output current	±128	mA
I _{OP}	DC output current peak (pulse at 1ms, 10% duty cycle)	±300	mA
I _{CC} or I _{GND}	DC V _{CC} or ground current	±100	mA
P _D	Power dissipation at T _A = 70 °C ⁽¹⁾	1120	mW
T _{stg}	Storage temperature	-65 to +150	°C
T _L	Lead temperature (10 sec)	300	°C

^{1.} Derate above 70 °C by 18.5 mW/°C.

4.1 Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parame	Value	Unit		
V_{CC}	Supply voltage		1.65 to 4.3	V	
V _I	Input voltage		0 to V _{CC}	V	
V _{IC}	Control input voltage		0 to 4.3	V	
V _O	Output voltage		0 to V _{CC}	V	
T _{op}	Operating temperature	Operating temperature			
dt/dv	Input rise and fall time control	V _L = 1.65 V to 2.7 V	0 to 20	ns/V	
uvuv	input	V _L = 3.0 to 4.3 V	0 to 10	115/V	

5 Electrical characteristics

Table 6. DC specifications

			e o. DC specifica			Value			
Symbol	Parameter	V _{CC} (V)	Test condition	T _A =	= 25 °C	;	-40 to 8	5 °C	Unit
				Min	Тур	Max	Min	Max	
		1.65 – 1.95		0.65 V _{CC}	_	-	0.65V _{CC}	_	
		2.3 – 2.5		1.2	-	-	1.2	_	
V_{IH}	High level input voltage	2.7 – 3.0	-	1.3	-	-	1.3	_	V
		3.3 – 3.6		1.4	-	-	1.4	_	
		4.3		1.6	_	_	1.6	_	
		1.65 – 1.95		-	_	0.25	-	0.25	
		2.3 – 2.5		_	_	0.25	-	0.25	
V_{IL}	Low level input voltage	2.7 – 3.0	-	_	_	0.25	_	0.25	V
		3.3 – 3.6		_	-	0.30	_	0.30	
				_	_	0.40	_	0.40	
V _{IH-INT}	High level input voltage for INT	4.3	-	2.4	_	-	2.4	_	V
V _{IL-INT}	Low level input voltage for INT	4.3	-	_	_	0.9	_	0.9	V
V _{OL-INT}	Low level output voltage for INT	4.3	I _O = 4 mA	-	-	0.40	-	0.50	V
		1.8		_	15.1	17.8	-	_	
		2.7		_	6.4	8.0	_	_	
R _{PEAK}	Switch ON peak resistance	3.0	$V_S = 0 V \text{ to } V_{CC}$ $I_S = 8 \text{ mA}$	_	5.9	7.5	_	_	Ω
		3.7		_	5.0	6.5	-	_	
		4.3		_	4.8	6.1	_	_	
D	Switch ON resistance	3.0	$V_S = 3 V$ $I_S = 8 \text{ mA}$	_	4.2	5.4	_	-	
R _{ON}	SWILLII OIN TESISIATICE	3.0	V _S = 0.4 V I _S = 8 mA	_	5.7	7.0	_	-	Ω

Electrical characteristics AS21P2THB

Table 6. DC specifications (continued)

						Value			
Symbol	Symbol Parameter		V _{CC} (V) Test condition		= 25 °C	;	-40 to 8	5 °C	Unit
				Min	Тур	Max	Min	Max	
		1.8		_	-	_	_	_	
		2.7		-	_	-	_	_	
ΔR_{ON}	ON resistance match between channels ⁽¹⁾	3.0	V _S at R _{ON} max I _S = 8 mA	_	0.1	-	_	_	Ω
		3.7	.5	_	_	_	_	_	
		4.3		_	_	_	_	_	
		1.8	$V_S = 0 \text{ V to } 0.4 \text{ V}$ $I_S = 8 \text{ mA}$	_	4.5	_	_	-	
		1.8		_	9.0	-	_	_	Ω
R _{FLAT}	ON resistance flatness ⁽²⁾	2.7		_	2.2	-	_	_	
	natile35	3.0	$V_S = 0 \text{ V to } V_{CC}$ $I_S = 8 \text{ mA}$	-	1.8	_	-	_	
		3.7	1.5 0	_	1.6	_	_	_	
		4.3		İ	1.6	ı	_	_	
I _{OFF}	OFF state leakage current (Sn), (D)	4.3	V _S = 0.3 or 4 V	-20	_	20	-100	100	nA
I _{IN}	Input leakage current	0 to 4.3	V _{SEL} = 0 to 4.3 V	-0.2	_	0.2	-1.0	1.0	μΑ
Icc	Quiescent supply current	1.65 to 4.3	V _{SEL} = VCC or GND	-0.2		0.2	-1.0	1.0	μA
	Quiescent supply		V _{SEL} = 1.65 V	_	±37	±50	_	±100	
I _{CCLV}	current for low voltage	4.3	V _{SEL} = 1.80 V	_	±33	±40	-	±50	μA
	driving		V _{SEL} = 2.60 V	ı	±11	±20	-	±30	

^{1.} ΔR_{ON} = max |mSN-nSN|, where m = 1, 2 and n = 1, 2, N = 1, 2

^{2.} Flatness is defined as the difference between the maximum and minimum value of on-resistance as measured over the specified analog signal ranges.

Table 7. AC characteristics (C_L = 35 pf, R_L: 50 Ω , T_R = T_f \leq 5 ns)

				F , <u>-</u>		Value			
Symbol	Parameter	V _{CC} (V)	Test conditions	TA	= 25 °C		-40 to	85 °C	Unit
				Min	Тур	Max	Min	Max	
		1.65 - 1.95		-	0.21	-	_	_	
	Propagation	2.3 - 2.7		_	0.15	-	-	_	ne
t _{PLH} , t _{PHL}	delay	3.0 - 3.3	_	_	0.14	_	_	_	ns
		3.6 - 4.3		_	0.13	_	_	_	
		1.65 - 1.95	V _S = 0.8 V	_	34	_	_	_	
_	Turns on times	2.3 - 2.7	V _S = 1.5 V	-	20	23	_	26	
t _{ON}	Turn on time	3.0 - 3.3		_	15	17	_	20	ns
		3.6 - 4.3		_	13	15	_	17	
		1.65 - 1.95	V _S = 0.8 V	_	27	-	-	_	
	Turn off time	2.3 - 2.7		_	19	22	-	25	20
t _{OFF}	Turri on time	3.0 - 3.3	V _S = 1.5 V	_	14	16	-	18	ns
		3.6 - 4.3		_	11	13	-	14	
		1.65 - 1.95		_	10	-	-	_	
	Break-before-		$C_L = 35 \text{ pF}$ $R_L = 50 \Omega$ $V_S = 1.5 \text{ V}$	-	6	_	_	_	200
t _D	make time delay	3.0 - 3.3		-	4	_	-	_	ns
		3.6 - 4.3		-	3	_	_	_	

Table 8. AC electrical characteristics (C $_{L}$ = 5 pF, R $_{L}$ = 50 Ω , T $_{A}$ = 25 °C)

						Value			
Symbol	Parameter	V _{CC} (V)	Test conditions	Т	A = 25 °	С	-40 to	85 °C	Unit
			Conditions	Min	Тур	Max	Min	Max	
		1.65		-	3.9	-	-	_	
Q	Charge injection	2.0	C _L = 100 pF	-	4.8	-	-	_	»C
Q	Charge injection	3.0	$V_{GEN} = 0 V$ $R_{GEN} = 0 \Omega$	-	5.2	-	-	_	рC
		4.3	32.1	_	6.4	-	_	_	
OIRR	OFF isolation ⁽¹⁾	1.65 – 4.3	V _S = 1V _{RMS} , f = 1 MHz Signal = 0 dBm	-	-78	-	-	-	dB
Ollar	Of F Isolation	$V_S = 1 V_{RMS}$, $f = 10 MHz$	$V_S = 1 V_{RMS}$	-	-57	_	_	_	uБ
Xtalk	Crosstalk	1.65 – 4.3	$V_S = 1 V_{RMS}$, f = 1 MHz Signal = 0 dBm	_	-78	_	_	_	dB
Alaik	Crossiaik	1.05 – 4.5	$V_S = 1V_{RMS}$, f = 10 MHz Signal = 0 dBm	_	-58	_	_	-	uв
BW	-3dB bandwidth	3.0 – 4.3	$R_L = 50 \Omega$ Signal = 0 dBm	_	800	-	-	_	MHz
C _{IN}	Control pin input capacitance		V _{CC} = 0 V	-	2	-	_	_	
C _{ON}	Sn port capacitance when switch is enabled	3.3	f = 240 MHz	_	6	_	_	-	pF
C _{OFF}	Sn port capacitance when switch is disabled	3.3	f = 240 MHz	-	2	-	-	-	

^{1.} Off isolation = 20 Log10 (V_D/V_S), V_D = output, V_S = input to off switch.

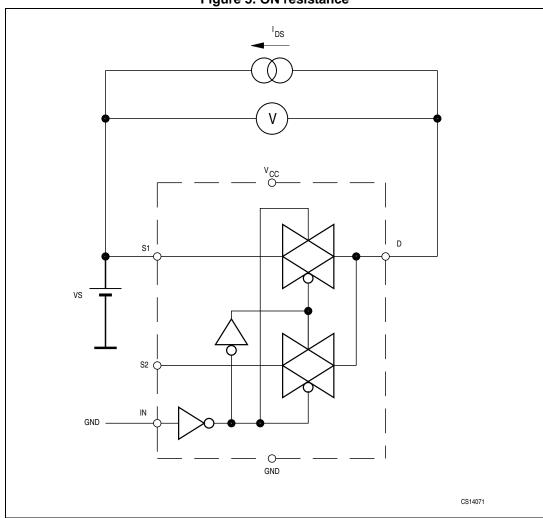
Table 9. USB related AC electrical characteristics

						Value			
Symbol	Parameter	V _{CC} (V)	Test conditions		T _A = 25 °C		-40 to	85 °C	Unit
				Min	Тур	Max	Min	Max	
t _{SK(0)}	Channel-to- channel skew	3.0 - 3.6	C _L = 10 pF	-	26	-	-	-	ps
t _{SK(P)}	Skew of opposite transition of the same output	3.0 - 3.6	C _L = 10 pF	-	60	-	-	-	ps
T _J	Total jitter	3.0 - 3.6	$R_L = 50 \Omega$ $C_L = 10 pF$ $t_R = t_F =$ 750 ps at 480 Mbps	_	130	_	_	_	ps

Test circuit AS21P2THB

6 Test circuit

Figure 5. ON resistance



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AS21P2THB Test circuit

Figure 6. OFF leakage

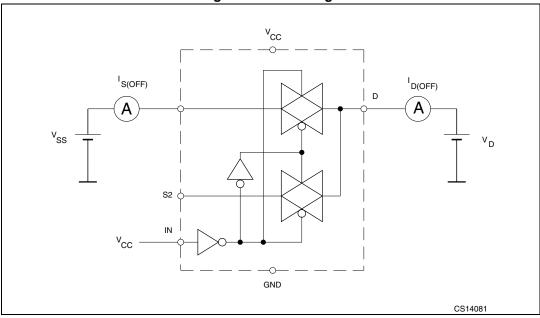
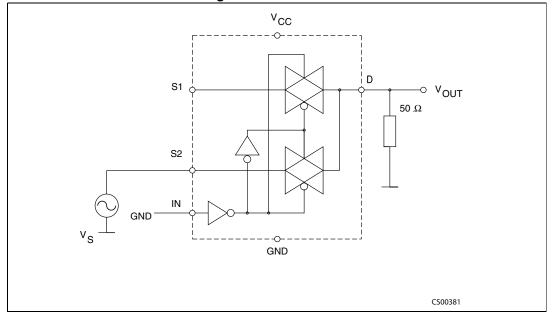


Figure 7. OFF isolation





Test circuit AS21P2THB

Figure 8. Bandwidth

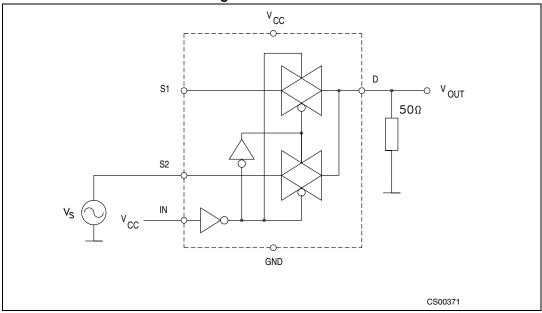
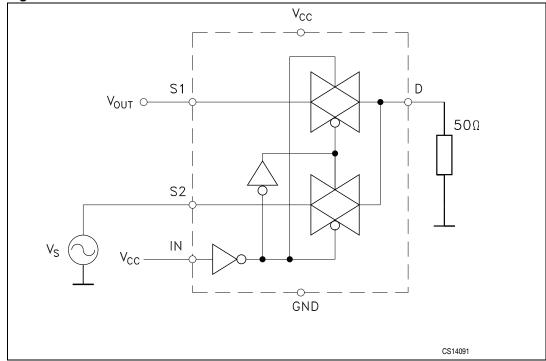


Figure 9. Channel-to-channel crosstalk



AS21P2THB Test circuit

PULSE GENERATOR D.U.T. R T C L R L SC08630

Figure 10. Test circuit

- 1. $C_L = 5/35 \text{ pF}$ or equivalent (includes jig and probe capacitance)
- 2. $R_L = 50 \Omega$ or equivalent
- 3. $R_T = Z_{OUT}$ of pulse generator (typically 50 Ω)

Test circuit AS21P2THB

V_{CC}

V_{OUT}

V_{IN}

50%

GND

90%

90%

90%

90%

Figure 11. Break-before-make time delay

V_{cc}

GND

S2

Figure 12. Switching time and charge injection (V_{GEN} = 0 V, R_{GEN} = 0 Ω , R_L = 1 M Ω , C_L = 100 pF)

CS14140

V_{OUT} OV

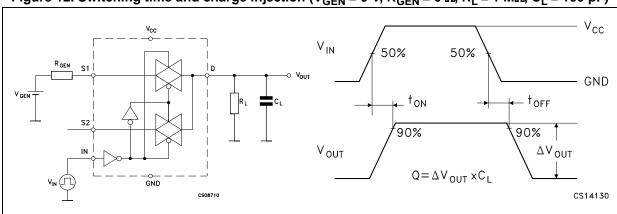
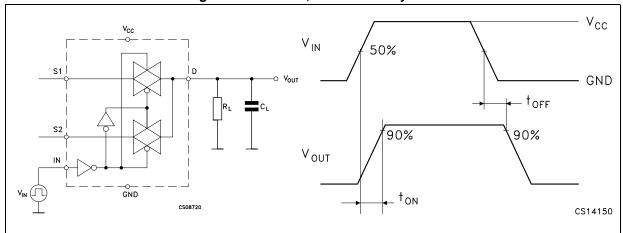


Figure 13. Turn ON, turn OFF delay time



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CS14120

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Package mechanical data 7

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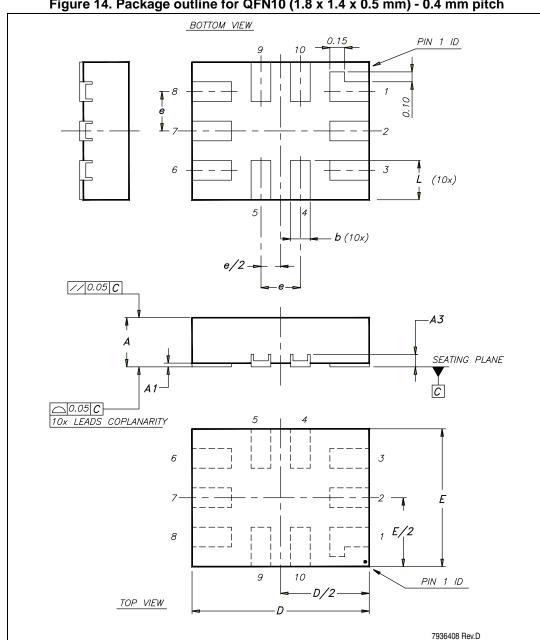


Figure 14. Package outline for QFN10 (1.8 x 1.4 x 0.5 mm) - 0.4 mm pitch

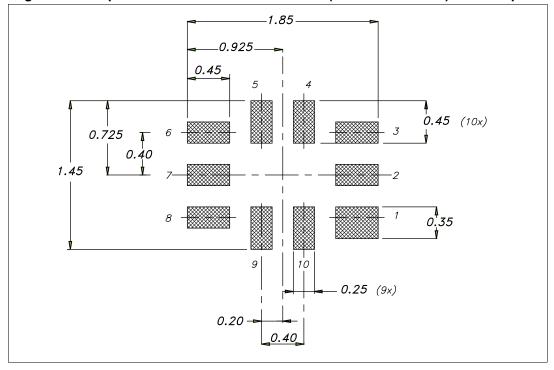
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Table 10. QFN10 (1.8 x 1.4 x 0.5 mm) - 0.4 mm pitch

Symbol		Millimeters	
Symbol	Min.	Тур.	Max.
Α	0.45	0.50	0.55
A1	0	0.02	0.05
A3		0.127	
b	0.15	0.20	0.25
D	1.75	1.80	1.85
E	1.35	1.40	1.45
е		0.40	
L	0.35	0.40	0.45

Figure 15. Footprint recommendations for QFN10 (1.8 x 1.4 x 0.5 mm) - 0.4 mm pitch



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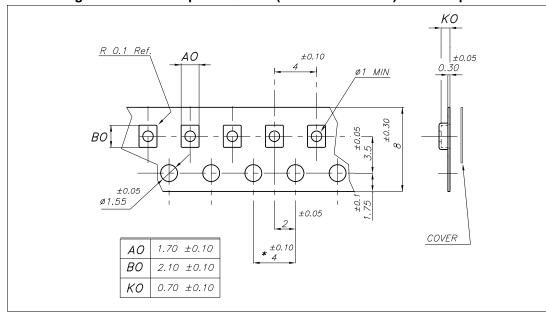


Figure 16. Carrier tape for QFN10 (1.8 x 1.4 x 0.5 mm) - 0.4 mm pitch



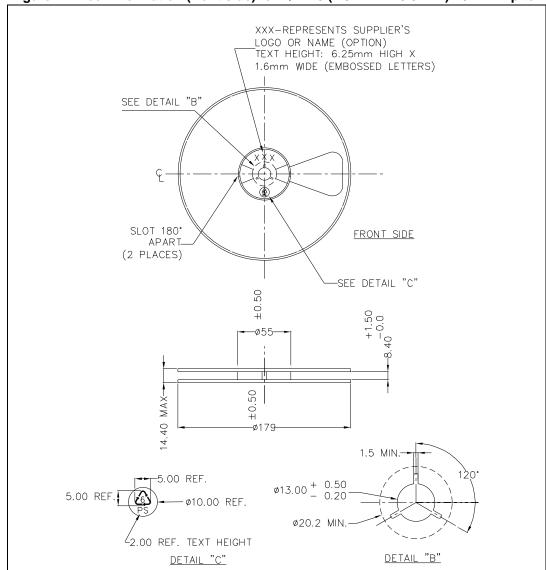


Figure 17. Reel information (front side) for QFN10 (1.8 x 1.4 x 0.5 mm) - 0.4 mm pitch

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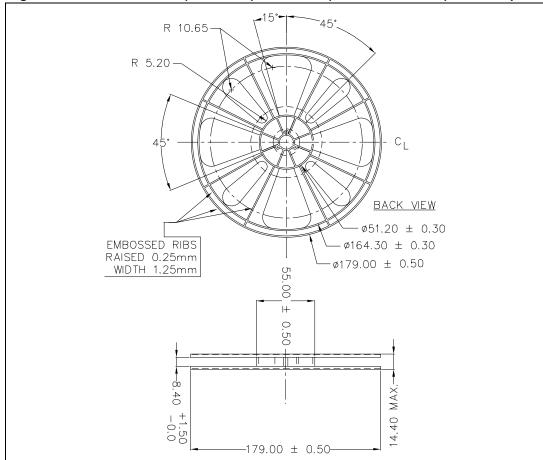


Figure 18. Reel information (back view) for QFN10 (1.8 x 1.4 x 0.5 mm) - 0.4 mm pitch



Revision history AS21P2THB

8 Revision history

Table 11. Document revision history

Date	Revision	Changes
07-Mar-2014	1	Initial release.

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